74HC74-Q100; 74HCT74-Q100

Dual D-type flip-flop with set and reset; positive edge-trigger

Rev. 2 — 6 September 2013 Product data sheet

1. General description

The 74HC74-Q100; 74HCT74-Q100 are dual positive edge triggered D-type flip-flop with individual data (nD), clock (nCP), set (nSD) and reset (nRD) inputs, and complementary nQ and nQ outputs. Data at the nD-input, that meets the set-up and hold time requirements on the LOW-to-HIGH clock transition, will be stored in the flip-flop and appear at the nQ output. The Schmitt-trigger action in the clock input, makes the circuit highly tolerant to slower clock rise and fall times. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of $V_{\rm CC}$.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
 - ◆ Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Input levels:
 - ◆ For 74HC74-Q100: CMOS level
 - ◆ For 74HCT74-Q100: TTL level
- Symmetrical output impedance
- Low power dissipation
- High noise immunity
- Balanced propagation delays
- Specified in compliance with JEDEC standard no. 7A
- ESD protection:
 - MIL-STD-883, method 3015 exceeds 2000 V
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V (C = 200 pF, R = 0 Ω)
- Multiple package options

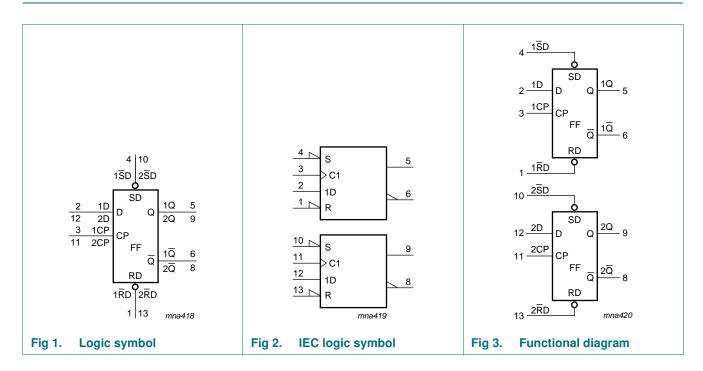


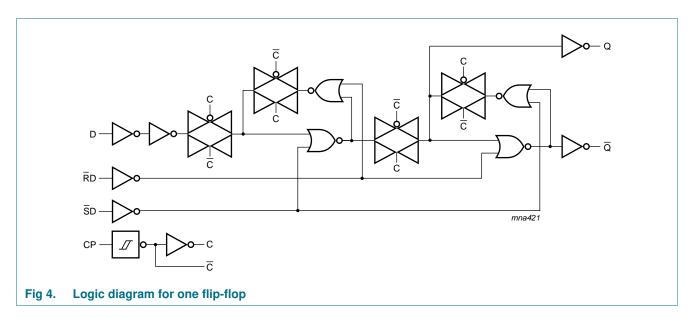
3. Ordering information

Table 1. Ordering information

Type number	Package				
	Temperature range	Name	Description	Version	
74HC74N-Q100	–40 °C to +125 °C	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1	
74HC74D-Q100	–40 °C to +125 °C	SO14	plastic small outline package; 14 leads; body	SOT108-1	
74HCT74D-Q100			width 3.9 mm		
74HC74PW-Q100	–40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package;	SOT402-1	
74HCT74PW-Q100			14 leads; body width 4.4 mm		
74HC74BQ-Q100	–40 °C to +125 °C	DHVQFN14	plastic dual in-line compatible thermal	SOT762-1	
74HCT74BQ-Q100			enhanced very thin quad flat package; no leads; 14 terminals; body $2.5 \times 3 \times 0.85$ mm		

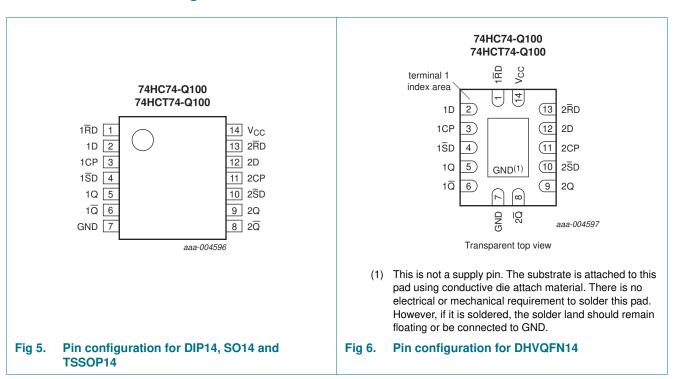
4. Functional diagram





5. Pinning information

5.1 Pinning



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5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1RD	1	asynchronous reset-direct input (active LOW)
1D	2	data input
1CP	3	clock input (LOW-to-HIGH, edge-triggered)
1SD	4	asynchronous set-direct input (active LOW)
1Q	5	output
1Q	6	complement output
GND	7	ground (0 V)
2Q	8	complement output
2Q	9	output
2 S D	10	asynchronous set-direct input (active LOW)
2CP	11	clock input (LOW-to-HIGH, edge-triggered)
2D	12	data input
2RD	13	asynchronous reset-direct input (active LOW)
V _{CC}	14	supply voltage

6. Functional description

Table 3. Function table[1]

Input		Output			
nSD	nRD	nCP	nD	nQ	nQ
L	Н	X	X	Н	L
Н	L	Χ	Χ	L	Н
L	L	Χ	Χ	Н	Н

^[1] H = HIGH voltage level; L = LOW voltage level; X = don't care.

Table 4. Function table[1]

Input		Output			
nSD	nRD	nCP	nD	nQ _{n+1}	nQ _{n+1}
Н	Н	\uparrow	L	L	Н
Н	Н	\uparrow	Н	Н	L

^[1] H = HIGH voltage level; L = LOW voltage level; ↑ = LOW-to-HIGH transition; Q_{n+1} = state after the next LOW-to-HIGH CP transition; X = don't care.

7. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$	-	±20	mA
I _{OK}	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	-	±20	mA
Io	output current	$V_O = -0.5 \text{ V to } (V_{CC} + 0.5 \text{ V})$	-	±25	mA
I _{CC}	supply current		-	+100	mA
I_{GND}	ground current		-100	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	DIP14 package	[1] -	750	mW
		SO14, TSSOP14 and DHVQFN14 packages	[1] -	500	mW

^[1] For DIP14 package: P_{tot} derates linearly with 12 mW/K above 70 °C.

For SO14 packages: Ptot derates linearly with 8 mW/K above 70 °C.

For TSSOP14 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.

For DHVQFN14 packages: Ptot derates linearly with 4.5 mW/K above 60 °C.

8. Recommended operating conditions

Table 6. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	Conditions 74HC74-Q100		100	74H	100	Unit	
			Min	Тур	Max	Min	Тур	Max	
V_{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V_{CC}	0	-	V_{CC}	V
Vo	output voltage		0	-	V_{CC}	0	-	V_{CC}	V
T_{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C
$\Delta t/\Delta V$	input transition rise and fall rate	$V_{CC} = 2.0 \text{ V}$	-	-	625	-	-	-	ns/V
		$V_{CC} = 4.5 \text{ V}$	-	1.67	139	-	1.67	139	ns/V
		$V_{CC} = 6.0 \text{ V}$	-	-	83	-	-	-	ns/V

9. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol Parameter		Conditions	T _{amb} =	$T_{amb} = -40$ °C to +85 °C			$T_{amb} = -40$ °C to +125 °C		
			Min	Typ[1]	Max	Min	Max		
74HC7	'4-Q100		'	'	'		'	'	
V_{IH}	HIGH-level	$V_{CC} = 2.0 \text{ V}$	1.5	1.2	-	1.5	-	V	
	input voltage	$V_{CC} = 4.5 \text{ V}$	3.15	2.4	-	3.15	-	V	
		$V_{CC} = 6.0 \text{ V}$	4.2	3.2	-	4.2	-	V	

74HC_HCT74_Q100

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 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T _{amb} =	= -40 °C to	+85 °C	$T_{amb} = -40$	°C to +125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V _{IL}	LOW-level	$V_{CC} = 2.0 \text{ V}$	-	0.8	0.5	-	0.5	٧
	input voltage	$V_{CC} = 4.5 \text{ V}$	-	2.1	1.35	-	1.35	٧
		$V_{CC} = 6.0 \text{ V}$	-	2.8	1.8	-	1.8	٧
V_{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL}						
	output voltage	$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.84	4.32	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.34	5.81	-	5.2	-	V
V_{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}						
	output voltage	$I_{O} = 4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.33	-	0.4	V
		$I_{O} = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.33	-	0.4	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±1.0	-	±1.0	μΑ
lcc	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	40	-	80	μΑ
Cı	input capacitance			3.5				pF
74HCT7	4-Q100							
V _{IH}	HIGH-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2.0	1.6	-	2.0	-	V
V_{IL}	LOW-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	1.2	8.0	-	0.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$						
	output voltage	$I_O = -4 \text{ mA}$	3.84	4.32	-	3.7	-	٧
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$						
	output voltage	$I_{O} = 4.0 \text{ mA}$	-	0.15	0.33	-	0.4	٧
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±1.0	-	±1.0	μΑ
cc	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	40	-	80	μΑ
Δl _{CC}	additional supply current	$\begin{aligned} &V_I = V_{CC} - 2.1 \text{ V};\\ &\text{other inputs at } V_{CC} \text{ or GND};\\ &V_{CC} = 4.5 \text{ V to } 5.5 \text{ V};\\ &I_O = 0 \text{ A} \end{aligned}$						
		per input pin; nD, nRD inputs	-	70	315	-	343	μΑ
		per input pin; nSD, nCP input	-	80	360	-	392	μΑ
Cı	input capacitance			3.5				рF

^[1] All typical values are measured at T_{amb} = 25 °C.

10. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit see Figure 9.

Symbol	Parameter	Conditions		T _{amb} :	= -40 °C to	+85 °C	T _{amb} = -40	°C to +125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
74HC74	-Q100			ı	1	ı	ı	1	
t _{pd}	propagation delay	nCP to nQ, n \overline{Q} ; see Figure 7	[2]						
		$V_{CC} = 2.0 \text{ V}$		-	47	220	-	265	ns
		V _{CC} = 4.5 V		-	17	44	-	53	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	14	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$		-	14	37	-	45	ns
		\overline{NSD} to \overline{NQ} ; see Figure 8	[2]						
		$V_{CC} = 2.0 \text{ V}$		-	50	250	-	300	ns
		$V_{CC} = 4.5 \text{ V}$		-	18	50	-	60	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	15	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$		-	14	43	-	51	ns
		\overline{RD} to \overline{nQ} , \overline{nQ} ; see Figure 8	[2]						
		$V_{CC} = 2.0 \text{ V}$		-	52	250	-	300	ns
		$V_{CC} = 4.5 \text{ V}$		-	19	50	-	60	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	16	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}$		-	15	43	-	51	ns
t _t	transition	nQ, nQ; see Figure 7	[3]						
	time	$V_{CC} = 2.0 \text{ V}$		-	19	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}$		-	7	19	-	22	ns
		$V_{CC} = 6.0 \text{ V}$		-	6	16	-	19	ns
t _W	pulse width	nCP HIGH or LOW; see Figure 7							
		$V_{CC} = 2.0 \text{ V}$		100	19	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}$		20	7	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$		17	6	-	20	-	ns
		nSD, nRD LOW; see <u>Figure 8</u>							
		$V_{CC} = 2.0 \text{ V}$		100	19	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}$		20	7	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}$		17	6	-	20	-	ns
t _{rec}	recovery	nSD, nRD; see Figure 8							
	time	$V_{CC} = 2.0 \text{ V}$		40	3	-	45	-	ns
		$V_{CC} = 4.5 \text{ V}$		8	1	-	9	-	ns
		$V_{CC} = 6.0 \text{ V}$		7	1	-	8	-	ns

 Table 8.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit see Figure 9.

Symbol	Parameter	Conditions		T _{amb}	= -40 °C to	o +85 °C	$T_{amb} = -40$	°C to +125 °C	Unit
			•	Min	Typ[1]	Max	Min	Max	
t _{su}	set-up time	nD to nCP; see Figure 7				1			
		$V_{CC} = 2.0 \text{ V}$		75	6	-	90	-	ns
		$V_{CC} = 4.5 \text{ V}$		15	2	-	18	-	ns
		$V_{CC} = 6.0 \text{ V}$		13	2	-	15	-	ns
t _h	hold time	nD to nCP; see Figure 7							
		$V_{CC} = 2.0 \text{ V}$		3	-6	-	3	-	ns
		$V_{CC} = 4.5 \text{ V}$		3	-2	-	3	-	ns
		$V_{CC} = 6.0 \text{ V}$		3	-2	-	3	-	ns
f _{max}	maximum	nCP; see Figure 7							
	frequency	$V_{CC} = 2.0 \text{ V}$		4.8	23	-	4.0	-	MHz
		$V_{CC} = 4.5 \text{ V}$		24	69	-	20	-	MHz
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	76	-	-	-	MHz
		$V_{CC} = 6.0 \text{ V}$		28	82	-	24	-	MHz
C_{PD}	power dissipation capacitance	$C_L = 50 \text{ pF}; f = 1 \text{ MHz};$ $V_I = \text{GND to } V_{CC}$	[4]	-	24	-	-	-	pF
74HCT7	4-Q100								
t _{pd}	propagation delay	nCP to nQ, n \overline{Q} ; see Figure 7	[2]						
		V _{CC} = 4.5 V		-	18	44	-	53	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	15	-	-	-	ns
		\overline{NSD} to \overline{NQ} ; see Figure 8	[2]						
		$V_{CC} = 4.5 \text{ V}$		-	23	50	-	60	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	18	-	-	-	ns
		\overline{RD} to \overline{nQ} , \overline{nQ} ; see Figure 8	[2]						
		$V_{CC} = 4.5 \text{ V}$		-	24	50	-	60	ns
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	18	-	-	-	ns
t _t	transition	nQ, nQ; see Figure 7	[3]						
	time	$V_{CC} = 4.5 \text{ V}$		-	7	19	-	22	ns
t _W	pulse width	nCP HIGH or LOW; see Figure 7							
		$V_{CC} = 4.5 \text{ V}$		23	9	-	27	-	ns
		nSD, nRD LOW; see <u>Figure 8</u>							
t _{rec}	recovery	$V_{CC} = 4.5 \text{ V}$ nSD, nRD; see Figure 8		20	9	-	24	-	ns
·rec	time	$V_{CC} = 4.5 \text{ V}$		8	1	_	9	_	ns
t _{su}	set-up time	$v_{CC} = 4.5 \text{ V}$ nD to nCP; see Figure 7		o	I	-	J	-	115
	ser-up iiiie	IID LU IIDE, SEE FIGURE /							

Table 8. Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit see Figure 9.

Symbol	Parameter	Conditions		$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$			$T_{amb} = -40$	Unit	
				Min	Typ[1]	Max	Min	Max	
t _h hold time	nD to nCP; see Figure 7	'		'		'	'		
		$V_{CC} = 4.5 \text{ V}$		3	-3	-	3	-	ns
f _{max} maximum		nCP; see Figure 7							
	frequency	$V_{CC} = 4.5 \text{ V}$		22	54	-	18	-	MHz
		$V_{CC} = 5 \text{ V}; C_L = 15 \text{ pF}$		-	59	-	-	-	MHz
C_{PD}	power dissipation capacitance	C_L = 50 pF; f = 1 MHz; V_I = GND to V_{CC} – 1.5 V	[4]	-	29	-	-	-	pF

- [1] All typical values are measured at T_{amb} = 25 °C.
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [3] t_t is the same as t_{THL} and t_{TLH} .
- [4] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum (C_L \times V_{CC}{}^2 \times f_o)$$
 where:

 f_i = input frequency in MHz;

 $f_o = output frequency in MHz;$

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$

11. Waveforms

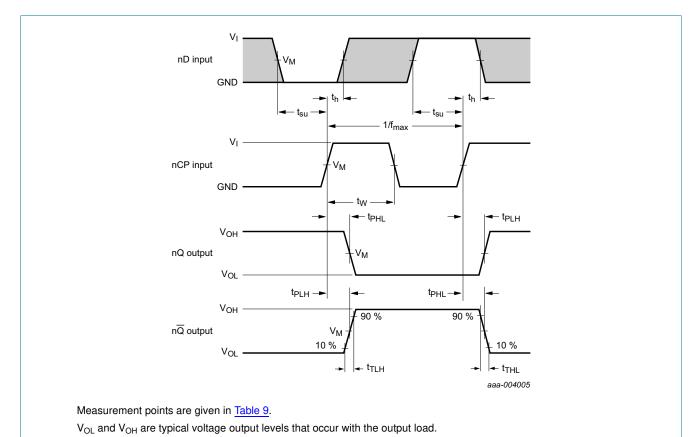
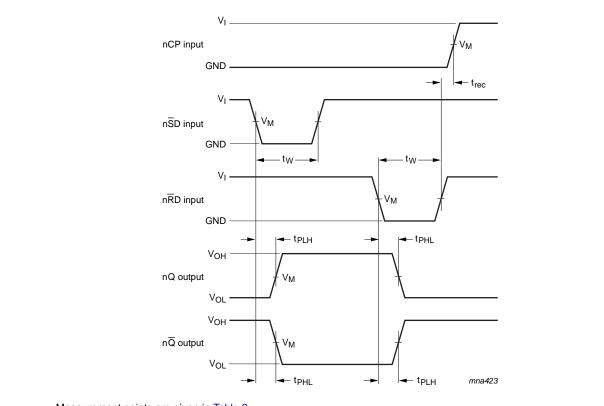


Fig 7. Propagation delay input (CP) to output (Qn), output transition time, clock input (CP) pulse width and the maximum frequency (CP)



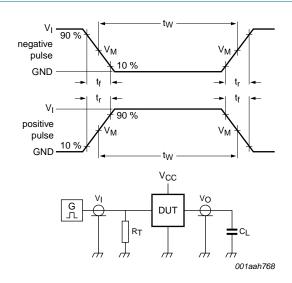
Measurement points are given in Table 9.

 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 8. The set (nSD) and reset (nRD) input to output (nQ,nQ) propagation delays, set and reset pulse widths and the nSD, nRD to nCP recovery time

Table 9. Measurement points

Туре	Input	Output
	V _M	V_{M}
74HC74-Q100	0.5V _{CC}	0.5V _{CC}
74HCT74-Q100	1.3 V	1.3 V



Test data is given in Table 10.

Definitions test circuit:

 R_T = Termination resistance should be equal to output impedance Z_0 of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistance.

S1 = Test selection switch.

Fig 9. Test circuit for measuring switching times

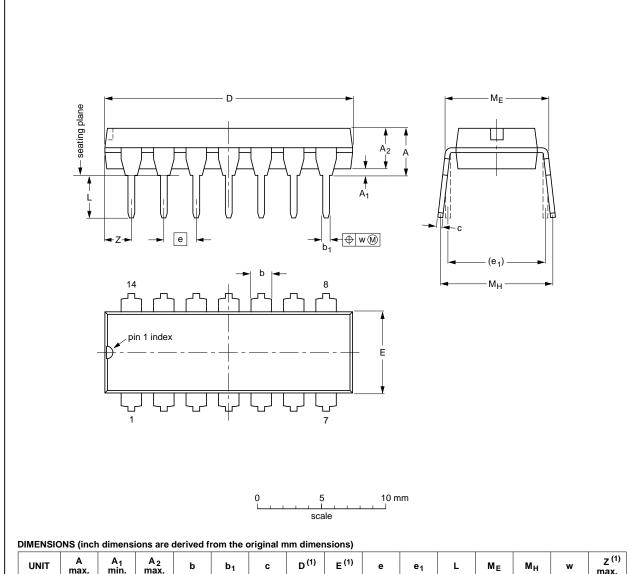
Table 10. Test data

Туре	Input		Load	Load				
	Vı	t _r , t _f	CL	R _L				
74HC74-Q100	V _{CC}	6 ns	15 pF, 50 pF	1 kΩ	t _{PLH} , t _{PHL}			
74HCT74-Q100	3 V	6 ns	15 pF, 50 pF	1 kΩ	t _{PLH} , t _{PHL}			

12. Package outline

DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	Мн	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.02	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

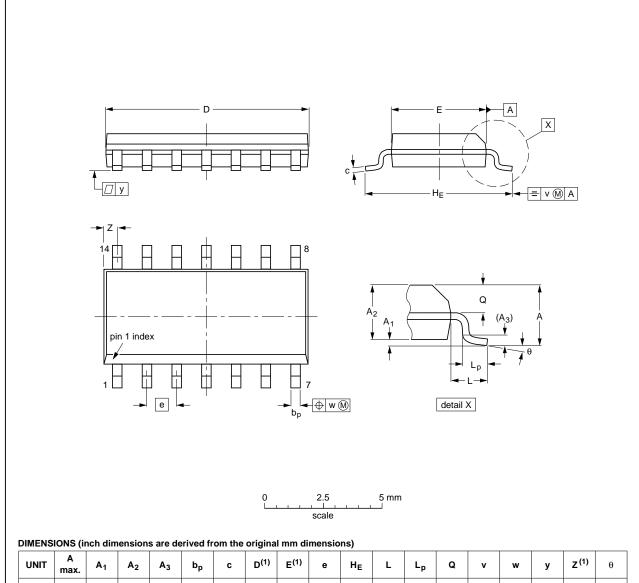
1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001	SC-501-14		99-12-27 03-02-13

Fig 10. Package outline SOT27-1 (DIP14)

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01	1	0.0100 0.0075	0.35 0.34	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012			99-12-27 03-02-19

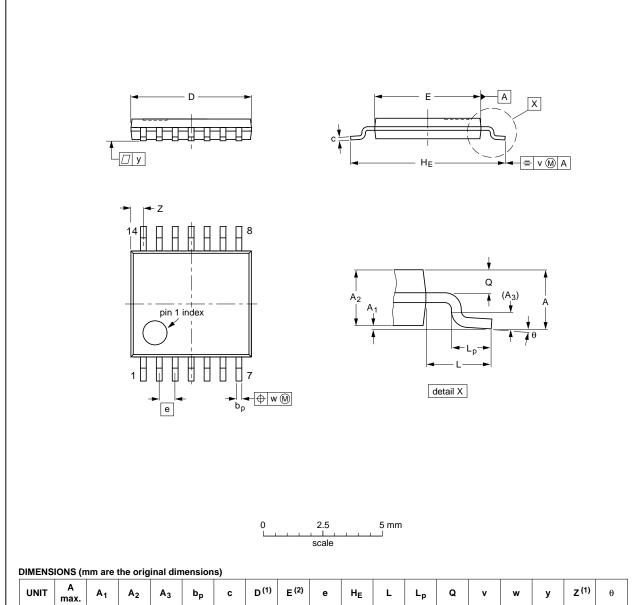
Fig 11. Package outline SOT108-1 (SO14)

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TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1



						-,												
UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E (2)	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

VERSION IEC JEDEC JEITA PROJECTION SOT402-1 MO-153	OUTLINE		REFER	EUROPEAN	ISSUE DATE		
SO1402-1 MO-153 ++ #+++	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
03-02	SOT402-1		MO-153				99-12-27 03-02-18

Fig 12. Package outline SOT402-1 (TSSOP14)

DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 x 3 x 0.85 mm SOT762-1

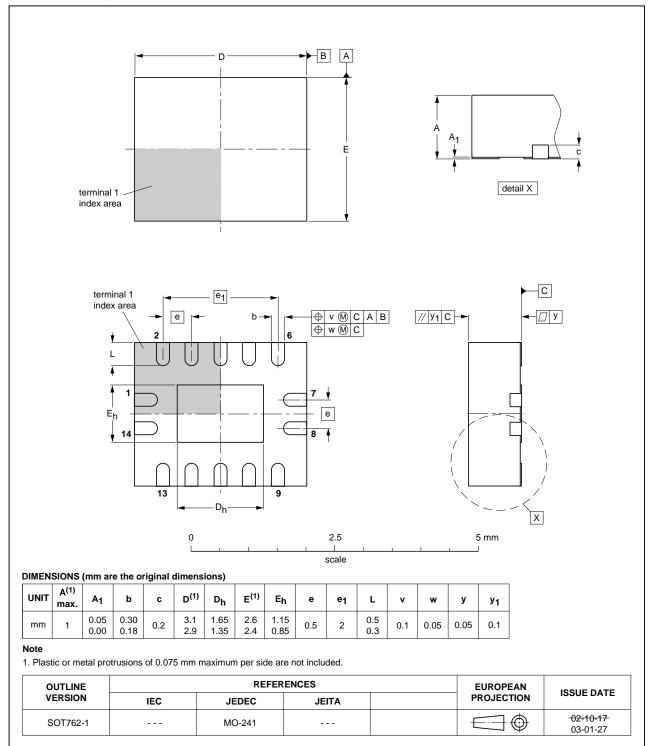


Fig 13. Package outline SOT762-1 (DHVQFN14)

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13. Abbreviations

Table 11. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MIL	Military
MM	Machine Model
TTL	Transistor-Transistor Logic

14. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT74_Q100 v.2	20130906	Product data sheet	-	74HC_HCT74_Q100 v.1
Modifications:	 74HC74N- 	Q100 (DIP14) added.		
74HC_HCT74_Q100 v.1	20120807	Product data sheet	-	-

15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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